Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/735,884	PAIK ET AL.	
Examiner	Art Unit	
LEE NGUYEN	2618	

SEARCHED				
Class	Subclass	Date	Examiner	
455	415 416 435.1	5/27/2005	LN	
	566 567			
379	93.23	5/27/2005	LN	
	142.06	-		
	142.17			
348	14.02	5/27/2005	LN	
	14.1			
UPDATE	SEARCH	8/1/2006	LN	
	ALL ABOVE			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		
SEE SEARC	CH HIŚTORY	8/1/2006	LN	

SEARCH NO (INCLUDING SEARCH	TES I STRATEGY)
	DATE	EXMR
EAST (USPG-PUB; USPAT) SEE PREVIOUS SEARCH HISTORY	5/27/2005	LN